Graphene-perovskite fibre photodetectors

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The integration of optoelectronic devices, such as transistors and photodetectors (PDs), into wearables and textiles is of great interest for applications such as healthcare and physiological monitoring. These require flexible/wearable systems adaptable to body motions, thus materials conformable to non-planar surfaces, and able to maintain performance under mechanical distortions. Here, we prepare fibre PDs combining rolled graphene layers and photoactive perovskites. Conductive fibres ($\sim 500\Omega/cm$) are made by rolling single layer graphene (SLG) around silica fibres, followed by deposition of a dielectric layer (Al₂O₃ and parylene C), another rolled SLG as channel, and perovskite as photoactive component. The resulting gate-tunable PDs have response time $\sim 5ms$, with an external responsivity $\sim 22kA/W$ at 488nm for 1V bias. The external responsivity is two orders of magnitude higher and the response time one order of magnitude faster than state-of-the-art wearable fibre based PDs. Under bending at 4mm radius, up to $\sim 80\%$ photocurrent is maintained. Washability tests show $\sim 72\%$ of initial photocurrent after 30 cycles, promising for wearable applications.

INTRODUCTION

Electronics on fibres and textiles is of interest for a range of applications, including healthcare (e.g. monitoring heart rate)[1], wearable displays[2], energy harvesting [3, 4] and storage [5]. The current vision for electronic-textiles is for them to be an integral part of everyday outfits[6, 7], and remain functional after washing[8]. One of the most common approaches to test the washability of e-textiles was developed by the American Association of Textile Chemists and Colorists (AATCC)[10]. One cycle in AATCC is equivalent to 5 regular-machine (household) washing cycles[9], achieved by the addition of steel or rubber balls to the washing container [9], with a gitator speed 179 ± 2 spm and spin speed 645 ± 15 rpm[10]. Washability tests are performed for at least 20 cycles[9], with each cycle being 45min at 40°C, with~0.37% volume of detergent (AATCC standard reference detergent 124[10]), and 10 stainless steel balls (6mm) or load ballast $(130\pm10g$ for cotton) to mimic abrasion[10, 11]. The analysis of washability depends on the intended application, the expected frequency of cleaning, and the total number of cleaning cycles during the tested product's lifetime. E.g., sports clothing will be mainly washed after every use[12], while a jacket will be cleaned once or twice a year [9, 13].

Bendability can be achieved by integrating rigid components (e.g. Si-based[14]) within flexible systems[15], including textiles[16]. However, device rigidity (i.e. intolerance to various forms of mechanical stress caused by body motions[17]), and washability issues[18] are bottlenecks towards commercialization[6]. Additionally, waferbased manufacturing processes are generally optimized for planar fabrication[19] and substrates[20].

Fibres are an ideal platform for wearable electronics due to their deformability [6, 21] and ease of integration into clothes [6, 21]. They can be used to cover various geometries to make functional surfaces for wearable electronics [22]. To achieve this, fibre-based conductors, semiconductors and insulators with controlled geometries and interfaces are required. These components could be used to integrate electronics into a textile during weaving[15], for applications such as light-harvesting[23, 24], light-generation[25], and photodetection[26]. The integration of photodetectors (PDs) into clothes would enable features such as photoplethysmography[17] (i.e. analysing the skin's optical absorption/reflectance to track changes in blood vessels' volume for cardiac pulse measurement[27]), and hazardous light detection (for skin cancer prevention [28]).

A number of fibre-based PDs were reported for wearable applications[28–32]. These can be compared via a number of key performance indicators (KPIs) including (i) external responsivity[33]:

$$R_{ext} = \frac{\triangle I_{ph}hc}{q.P_{opt}.\lambda.A_{PD}/A_0} \tag{1}$$

where I_{ph} is the photocurrent $(I_{ph}=I_{light}-I_{dark})$ the difference between current under illumination and in dark, h is the Planck' constant, c is the speed of light, q is the electron charge, P_{opt} is the impinging optical power, λ is the wavelength of the incident laser, A_{PD} and A_0 are the PD area and the laser spot size, respectively. A_{PD}/A_0 is a scaling factor taking into account that only

Structuro	Properties								
(Substrate)[Reference]	$\begin{array}{c} \mathbf{R}_{ext} \\ (\mathbf{A}/\mathbf{W}) \end{array}$	Spectral range (nm)	Rise/Fall time	D* (Jones)	Bending cycle	Washing cycle			
SLG/PVK (Fibre) [THIS WORK]	2.2×10^4 @1V 488nm	480-870	$5/35 \mathrm{ms}$	10^{13}	4mm 100 cycles	AATCC 30 cycles			
$\begin{array}{c} CuZnS/TiO_2\\ (Fibre) \ [28] \end{array}$	640 @3V 320-400nm	260-420	$200/200\mathrm{ms}$	-	60^0 200 cycles	-			
Carbon fibre/ZnO-CdS (Fibre) [31]	10^5 @2V 372nm	372-548	>1s	-	-0.38%strain -	-			
P3HT/ZNO (Fibre) [36]	$\begin{array}{c} 156 \mu \\ @0\mathrm{V} \ 365 \mathrm{nm} \end{array}$	365-880	40/40ms	$0.74 x 10^9$	1.96% strain -	-			
Carbon fibre/PVK (Fibre) [32]	0.563 @0V 800nm	350-1050	$200/200\mathrm{ms}$	2.15×10^{13}	90 ⁰ 60 cycles	-	e PDs		
PVK (PET) [121]	3.49 @3V 365nm	365-780	0.14/2.9s	-	ND 120 cycles	-	Flexibl		
PVK/PDPP3T (PET) [138]	$154 \mathrm{x} 10^{-3}$ @1V 835nm	365-835	-	8.8×10^{10}	7mm 1000 cycles	-			
$\begin{array}{c} \mathrm{SLG/MoS_2} \ (1\mathrm{L}) \\ (\mathrm{PET}) \ [124] \end{array}$	45.5 @1V 642nm	-	-	-	$14 \mathrm{mm}$ 30 cycles	-			
InP (PET) [136]	0.12 @-0.3V 533nm	533-980	-	-	38.1mm -	-			
SLG/PVK (PA) [137]	115 @1V 515nm	-	5.3s	$3x10^{12}$	12mm 3000 cycles	-			
$SLG/CsPbBr_3$ (Fibre(facet)) [29]	2×10^4 @0.2V 400nm	400-520	24.2s	8.6×10^{10}	NA	NA			
MoS_2 (1L) (Fibre(facet)) [30]	$\begin{array}{c} 0.6\\ @4\mathrm{V} \ 400\mathrm{nm} \end{array}$	-	7.1/3.5s	-	NA	NA			
PVK (Glass/ITO) [125]	27 @5V 830nm	400-830	$30/20\mu s$	10^{13}	NA	NA			
$\frac{\text{SLG}}{(\text{Si/SiO}_2)} [118]$	6.1×10^{-3} @0.4V 1150nm	300-6000	$16 \mathrm{GHz}$	-	NA	NA	PDs		
SLG/PVK (Si/SiO_2) [112]	SLG/PVK 180 Si/SiO ₂) [112] @0.1V 520nm		$87/540\mathrm{ms}$	10^{9}	NA	NA	Rigid		
SLG/PVK (Si/SiO_2) [122]	10^9 @0.5V 598nm	350-1100	4.5/57.5s	10^{14}	NA	NA			
$\frac{\rm SLG/QDs}{\rm (Si/SiO_2) \ [67]}$	10^{7} @5V 532nm	532-1600	$10/100\mathrm{ms}$	$7 x 10^{13}$	NA	NA			
$\frac{\rm SLG/MoS_2}{\rm (Si/SiO_2) \ [123]}$	10^{7} @1V 532nm	290-680	-	-	NA	NA			
Conductive microfluidized graphite-coated textile [37]	NA	NA	NA	NA	180 ⁰ 150 cycles	BS EN ISO 105 C06 A1S 10 cycles	ı PDs		
Polymer solar cells [38]	NA	NA	NA	NA	52% compression 20 cycles	Submersed in water 20 cycles	le Nor		
Textile-based field-effect transistors [71]	NA	NA	NA	NA	4mm -	Tumble-washed 20 cycles	Flexib		

TABLE I. Comparison of KPIs for PDs on rigid and flexible substrates. PA stands for polyamide. NA means not applicable. ND means not defined. The last three rows are neither PDs nor fibre-based structures. Ref.[37] reported 3.5 times higher resistance ($\sim 700\Omega/cm$) after 10 washing cycles. Ref.[37] used 10 home laundry washing cycles following a British Standard (BS EN ISO 105 C06 A1S). Ref.[38] reported $\sim 80\%$ of the initial power conversion efficiency after water immersion. Ref.[71] reported a $\sim 50\%$ drop in drain current after 20 washing cycles. Our PDs maintain up to $\sim 72\%$ I_{ph} after 30 AATCC cycles a fraction of optical power impinges on the PD, (ii) response time (τ_{res}), i.e. the lifetime of the photogenerated charges in the PD light absorbing layer[34], (iii) operating voltage[34, 35], (iv) R_{ext} or I_{ph} under mechanical distortion (e.g. bending)[26], and (v) washability, defined as the ability to withstand exposure to water and cleaning processes without being damaged or malfunctioning[26].

State-of-the-art wearable fibre-based PDs have $\tau_{res} \sim 40 \text{ms}[36]$ and $R_{ext} \sim 156 \mu \text{A/W}[36]$ at 365nm. Under bending strain~1.96%, Ref.[36] reported that R_{ext} was enhanced~80% by the piezo-phototronic effect (a three-way coupling of piezoelectric, semiconductor and photonic properties[36]) compared to no strain. Refs.[28, 32] measured $\tau_{res} \sim 200ms$ and $\mathrm{R}_{ext}~\sim 1.48 \mathrm{A/W[32]}$ at 800nm and $\sim 640 \mathrm{A/W[28]}$ under UV-A (320-400nm) at 0.5 and 3V, respectively. Bending to 90° up to 60 cycles [32] and 60° for 200cycles[28] resulted in~8% and~14% decrease of I_{ph} , respectively [28], see Table 1. However, Refs. [28, 32, 36] did not discuss washability. Refs. [37, 38] addressed washability in wearable e-textiles, but did not specifically focus on the washability of PD electronics. Ref.[37] reported microfluidized graphite (20% < 10 nm thickness)after 20 cycles of microfluidization) based poly-cotton fabric[37], with a polyurethane-based encapsulant to fabricate graphene-coated textile. They measured 3.5 times higher resistance ($\sim 700\Omega/cm$) after 10 washing cycles[37]. Ref.[38] showed washable polymer solar cells made of donor-acceptor polymer with quaterthiophene naphtho[1,2-c:5,6-c']bis[1,2,5]thiadiazoleand (NTz)(PNTz4T) and [6,6]-phenyl C_{71} -butyric acid methyl ester $(PC_{71}BM)$. Ref. [38] demonstrated that flexible photovoltaic modules encapsulated with $\sim 1 \mu m$ parylene and $\sim 500 \mu m$ acrylic elastomers maintained $\sim 80\%$ of the initial power conversion efficiency (i.e. the percentage of solar energy shining converted into usable electricity[35]) after being submersed in water for 100mins[38]. Ref.[30] prepared PDs on the end-face of an optical fibre using monolayer (1L) MoS_2 prepared by chemical vapor deposition (CVD). This was wet transferred and dip coated onto the fibre facet (end-face)[30]. Ref.[30] reported $R_{ext} \sim 0.6 A/W$ at 4V and 400nm, with rise time and fall times (i.e. the time for the signal to rise from 10% to 90% [35] or fall from 90% to 10% of the final value [35] \sim 7.1s and \sim 3.5s, respectively [30]. However, PD fabrication on fibres' facets is not practical for wearable applications, since fibres' facets can be covered and hindered during weaving[39], thus not being able to receive light[26]. PDs built parallel to the longitudinal axis of fibres are desired [26], so that the exposed portion receives light, and the covered conductive terminals transmit the signals. Ref.[31] prepared PDs made of ZnO-CdS double-shell nanowire arrays on carbon fibres[31], with $R_{ext} \sim 10^5 A/W$ at 372nm at 2V, τ_{res} $\sim\!\!>\!\!1\mathrm{s}[31]$ with operating wavelength from 372 to 548nm[31]. Ref.[32] reported fibre-shaped PDs

based on CH₃NH₃PbI₃ perovskite(PVK)/TiO₂/carbon fibres and Cu wires, achieving $\tau_{res} \sim 200$ ms, with R_{ext} ~ 1.48A/W under 0.5V at 800nm and 0.563A/W at a 0V bias at 800nm. Ref.[28] demonstrated fibre-shaped CuZnS/TiO₂ nanotubes PDs with Ti wires as inner electrodes and wrapped carbon nanotube around the wire as the outer electrode[28], with R_{ext} ~640A/W under UV-A (320-400nm) at 3V, $\tau_{res} \sim 200$ ms and operating wavelength~260-420nm, limited by the absorption of TiO₂ nanotubes[28]. However, none of these reported washability tests, see Table 1 for a summary.

Graphene and related materials (GRMs) are ideal for a variety of optoelectronics applications[41], such as PDs[34], solar cells[42–44], and modulators[45, 46]. Wafer-scale growth, transfer and fabrication of CVD SLG have improved over the years[47–49], with carrier mobility, μ , reaching~18500 $cm^2V^{-1}s^{-1}$ at room temperature on a rigid substrate such as Si/SiO₂[64]. CVD SLG without encapsulation on ethylene vinyl acetate (EVA)/polyethylene terephthalate (PET) was reported with μ up to~7000 $cm^2V^{-1}s^{-1}$ [50]. However, the absence of a gain mechanism that can generate multiple charge carriers from one incident photon, resulted in limited R_{ext} ~0.01A/W for SLG-only PDs[68].

PVKs are promising photoactive materials, due to their long(> 1 μ m[51]) charge-carrier diffusion lengths[51], strong (~10⁵cm⁻¹[52]) absorption coefficients[52], and bandgap tunability (from 1.1eV[53] to 2.5eV[53]) via chemical composition control[53]. PVKs could be applied for coloured emitters[54], energy harvesting[55], and PDs[56, 57]. PVKs based PDs have low R_{ext} ~0.4A/W in the UV–visible range (350-900nm)[58, 59], mainly due to low $\mu \sim 40cm^2V^{-1}s^{-1}$ [60], since R_{ext} is proportional to μ [33]:

$$R_{ext} = \frac{\Delta I}{P_{opt}} \frac{\tau_{life} \mu V_{ds}}{L^2} \tag{2}$$

where τ_{life} is the response time, V_{ds} is the bias applied between source and drain, and L is the channel length. The term $\frac{\tau_{life}\mu V_{ds}}{L^2}$ is called gain[33]. By increasing μ , the gain increases, which results in higher R_{ext} . Consequently, the combination of solution-processed PVK with SLG having μ well above PVK's, to enhance gain, is promising for light sensing and flexible applications.

Ref.[29] prepared PDs based on SLG and CsPbBr₃ PVK nanocrystals at the end-face of silica fibres with $R_{ext} \sim 2 \times 10^4 A/W$ under 400nm illumination. SLG was transferred onto the facet, followed by self-assembly of CsPbBr₃ nanocrystals[29]. However, the operating wavelength was~400-520nm, limited by the CsPbBr₃ nanocrystals absorptions[29], with $\tau_{res} \sim 24.2$ s, Table 1.

Here, we report a wet transfer approach to roll CVD SLG around silica fibres, to be used as a gate for flexible PDs. This is followed by the deposition of Al₂O₃ and parylene C as dielectrics. Another rolled SLG is used as channel with $\mu \sim 1300 cm^2 V^{-1} s^{-1}$ at RT, before

depositing $(Cs_{0.06}FA_{0.79}MA_{0.15})Pb(I_{0.85}Br_{0.15})_3,$ MA=methylammonium, CH_3NH^{3+} where and FA=formamidinium, $CH_3(NH_2)^{2+}$ PVK as photoactive layer. Our PVK does not degrade up to $85^{\circ}C[69]$ and is chemically stable (ions do not migrate to other layers (i.e. SLG)[70]. We get $R_{ext} \sim 22,000 \text{A/W}$ at 488nm, with rise and fall times \sim 5ms and \sim 35ms, respectively, at 1V, outperforming R_{ext} of fibre-based PDs by at least two orders of magnitude [28, 30, 32] and one order of magnitude in $\tau_{res}[28, 29, 32]$, Table 1. Bending and washing tests are also performed. After 100 bending cycles at 4mm bending radius I_{ph} is~80% of the non-bent one. After 20 and 30 washing cycles according to the AATCC standard[10] we get $\sim 6\%$ and $\sim 28\%$ degradation of I_{ph} . The washability of our fibre-based PDs goes beyond the typical 20 cycles reported for textile-based field-effect transistors (FETs)[71]. Ref.[71] had a~50% drop in drain current after 20 cycles[71]), while our PDs maintain up to 72% I_{ph} after 30 cycles, compared to unwashed fibre-based PDs, making them promising for wearable applications.

RESULTS AND DISCUSSION

Fig.1 plots a scheme of the transfer process of CVD SLG around fibres. CVD SLG is prepared on a $35\mu m$ Cu foil as for Ref. [72]. The Cu foil is annealed up to $1000^{\circ}C$ for 30mins under H₂ at 20sccm. Then, a gas mixture of CH_4 (5sccm) and H_2 (20sccm) is added to initiate growth at 1000°C for 30mins. Finally, the sample is cooled in vacuum (1mTorr) to RT. In order to transfer SLG, poly(methyl methacrylate) (PMMA) dissolved in acetone is spin coated on SLG/Cu at 4000rpm for 40s, followed by oxygen etching of SLG on the Cu backside using an RIE-NanoEtch (3W, 30s)[72, 73]. Cu/SLG/PMMA is then transferred to an aqueous ammonium persulfate (APS) solution ($(NH_4)_2S_2O_8$, 0.5 mol/L) for Cu dissolution [72, 73]. The PMMA membrane and CVD SLG are then cleaned of APS residuals by dipping in DI water for 20mins. This is followed by the rolling process. First, the fibre is placed on a supporting film (e.g. poly(ethylene terephthalate) (PET)) and the edge of the floating SLG/PMMA is fished onto the fibre, while the rest of the SLG/PMMA stays on the supporting film. Then, the fibre is rotated clockwise at ~ 10 rpm to roll SLG/PMMA. The PMMA layer is then removed by immersing the coated fibre in acetone for 15mins, followed by rinsing with isopropanol for 10 mins and drying in N_2 . Fig.1b is the top view of 6 SLG layers coated on fibre glass, taken by scanning electron microscopy (SEM, Magellan 400L). Fig.1c shows the cross-section.

Fig.1d plots the conductivity (measured via a Keithley source meter at the two ends of the channel layer) of different coated fibres depending on the number of rolled SLG, N_R , for a channel length~1mm. The linear relation between current and voltage indicates Ohmic conductivity. Given that increasing N_R reduces sheet resistance[42] due to increased levels of conductive paths[74], N_R=6 is chosen as a gate electrode. N_R=10 leads to 284Ω/mm, however the roughness caused by PMMA residuals between layers could result in a short circuit when the dielectric layer is positioned between gate and channel layer. Thus, we use N_R=6 to fabricate conductive fibres with a uniform surface coverage of SLG as for Figs.1b,c.

The presence and quality of SLG are further studied by Raman spectroscopy at 514.5nm using a Renishaw InVia with a 50× objective and <0.1mW power on the sample. Fig.2 plots the Raman spectrum of the film as grown on Cu. The 2D peak is a single Lorentzian with FWHM(2D)~34cm⁻¹, signature of SLG[76]. The position of the G peak, Pos(G), is~1591cm⁻¹, with FWHM(G)~22cm⁻¹. The 2D peak position, Pos(2D), is~2720cm⁻¹, with FWHM(2D)~34cm⁻¹, while the 2D to G peak intensity and area ratios, I(2D)/I(G) and A(2D)/A(G), are~4.4 and~6.7. No D peak is observed, indicating negligible defects[77]. Fig.2 plots Raman spectra of CVD SLG for N_R=1, 2, 4, 6, 8, 10. The 2D line shape is independent of N_R, suggesting no interaction between transferred SLGs[77, 78], Fig.2.

Fig.3 plots Pos(G), FWHM(G), Pos(2D), FWHM(2D), I(2D)/I(G), A(2D)/A(G), I(D)/I(G) as a function of N_R . For each N_R , 10 points are collected along the fibre. I(2D)/I(G) changes from ~2.4 for $N_R=1$ to ~1.7 for N_R=10, Fig.3a. A(2D)/A(G) changes from~4 for $N_R=1$ to ~2.9 for $N_R=10$, Fig.3b. The decrease in I(2D)/I(G) and A(2D)/A(G) indicates doping increases from $E_F \sim 225 \text{meV}$ for $N_R=1$ to $\sim 320 \text{meV}$ for $N_{R}=10[79, 80]$. This is further supported by the decrease of Pos(G) as function of N_R from~1585.4cm⁻¹ for $N_R=1$ to 1584.3 cm^{-1} for N_R=10, Fig.3d. From I(D)/I(G), Fig.3g, the defect density changes from $\sim 5.74 \times 10^{10} \text{ cm}^{-2}$ for $N_R=1$ to $7.1 \times 10^{10} \text{ cm}^{-2}$ for $N_R=10[81, 82]$ for excitation energy 2.41eV and $E_F \sim 225 \text{meV}$ and 320 meV, respectively, Fig.3g. FWHM(2D,G) are broadened as N_R increases due to defects and inhomogeneities of rolled CVD graphene, Figs.3c,e.

For N_B=6, Pos(G)~1584cm⁻¹, FWHM(G)~21cm⁻¹. $Pos(2D) \sim 2694 cm^{-1}$, $FWHM(2D) \sim 38 cm^{-1}$. $I(2D)/I(G) \sim 1.7 A(2D)/A(G) \sim 2.9$, indicating p doping with $E_F \sim 310 \text{meV}$ by taking into account the dielectric constant ~ 3.9 of the silica fibre [83]. $I(D)/I(G) \sim 0.1$ corresponds to a defect density $\sim 4.9 \times 10^{10} \text{cm}^{-2}[81, 82]$. Pos(G,2D) are affected by the presence of strain. Biaxial strain can be differentiated from uniaxial from the absence of G-peak splitting with increasing strain[84]. however at low ($\leq 0.5\%$) strain the splitting cannot be resolved[84, 85]. For uniaxial(biaxial) strain, Pos(G) shifts by $\Delta Pos(G)/\Delta \epsilon_{strain} \sim 23(60) \text{cm}^{-1}/\%[84, 85].$ Pos(G) also depends on doping[79, 80]. However, Pos(2D) and Pos(G) are not correlated, Fig.3h. Thus, the spread of Pos(G) and Pos(2D) is mostly due to



FIG. 1. (a) Scheme of the transfer process for CVD SLG around fibres. (b) Top view SEM images for $N_R=6$. (c) Cross-section SEM image for $N_R=6$. (d) The current vs voltage of fibres as a function of N_R .



FIG. 2. 514.5nm Raman spectra of CVD SLG on Cu and for $N_R=1, 2, 4, 6, 8, 10$, normalized to have the same I(G).

doping. Table 2 summarizes the Raman fit parameters and resulting E_F , doping type, strain, defect density.

Fig.4 is a schematic drawing of our fibre-based PDs. The fabrication process starts by wiping the silica fibre via acetone and isopropanol, Fig.4a. Then, CVD SLG is rolled 6 times around the fibre (reaching a conductivity $\sim 500\Omega/\text{mm}$ to form a gate electrode, Fig.4b). Then, 150 nm Al₂O₃ and 200 nm parylene C are deposited as gate-dielectrics, Fig.4c. Al₂O₃ is commonly used as a gate dielectric in graphene fieldeffect transistors[86] because of its dielectric constant $(k \sim 9)[87, 88]$, compatibility with graphene[88] and breakdown voltage (up to 10 MV/cm)[87]. Parylene is also commonly employed as dielectric, pin-hole free[89, 90], passivation layer[91] in flexible electronics[92, 93]. Al_2O_3 coating is performed by atomic layer deposition (ALD, Cambridge Nanotech Savannah), to achieve uniform coating and film thickness control (down to the



FIG. 3. 514.5nm Raman spectra for $N_R=1$, 2, 4, 6, 8, 10. For each N_R , 10 points are collected along the fibre. (a-g) Average and standard deviations of (a) I(2D)/I(G), (b) A(2D)/A(G), (c) FWHM(G), (d) Pos(G), (e) FWHM(2D), (f) Pos(2D), (g) I(D)/I(G). (h) Pos(2D) as a function of Pos(G).

nm range)[94]. We deposit a 150nm-thick Al_2O_3 dielectric layer at 150°C at a base pressure~0.5mbar using trimethylaluminum (TMA purity >98%, Strem Chemicals 93-1360) as precursor and H_2O as oxidant. Oxidant and precursors are alternately introduced into the chamber in a 20sccm flow of N₂ carrier gas. If Al_2O_3 alone is used, we get dielectric failure because of crack formation, due to the mechanical stress/strain involved in the fabrication process of our PDs. 200nm parylene is applied as follows. A parylene dimer is vaporized at 80°C, then, in a separate chamber, it is pyrolysed into monomers at 690°C. The fibre is held at room temperature (RT), so that the parylene polymerizes on contact with the sur-



FIG. 4. Fibre-based SLG/PVK PDs fabrication process. (a) Silica fibre substrate. (b) $N_R=6$ around the fibre as gate electrode. (c) Gate dielectric layer composed of Al₂O₃ and parylene C. (d) Rolled $N_R=6$ channel. (e) Spin-coated PVK on rolled CVD SLG channel. (f) Assembled fibre-based SLG/PVK PD.

face. The physical vapor deposition of parylene provides coverage of all accessible surfaces [95]. This improves dielectric robustness against deformations during manufacturing of fibre-based PDs, reducing the risk of short circuits. The sole use of parylene C, however, creates inconsistent dielectric properties: thin layers (\sim 500nm) result in gate leakage at low (\sim 0.2MV/m) electric fields, while exceeding 500nm compromises the channel modulation due to a decrease in gate dielectric capacitance[96].

Fig.5 plots the Raman spectra of the fibre PD at different fabrication stages. Raman spectra of fibre (red), dielectric layer (150nm Al_2O_3 and 200nm parylene C) (blue), $N_R=6$ on the dielectric layer (green), and coated PVK on $N_R=6$ (orange). In the Raman spectrum of Al_2O_3 and parylene C, Fig.5c, the peaks~1337cm⁻¹, 1440cm^{-1} , 1610cm^{-1} , Fig.5c, are attributed to CH_2 wagging and twisting vibrations [97, 98], CH scissoring in CH_2 and/or C-C skeletal in-plane vibrations of aromatic rings[97, 98], and CH scissoring in CH₂ and/or C-C skeletal in-plane vibrations of aromatic rings[97, 98], $Pos(G) \sim 1587 cm^{-1}$ respectively. For $N_R=6,$ $Pos(2D) \sim 2686 cm^{-1}$. $FWHM(G) \sim 17 cm^{-1}$ $FWHM(2D) \sim 41 cm^{-1}$, $I(2D)/I(G) \sim 1.9$ and $Pos(2D) \sim 2686 cm^{-1}$ indicates $A(2D)/A(G) \sim 4.7.$ that layers are p-doped[80]. From $A(2D)/A(G) \sim 4.7$ we estimate $E_F \sim 190 \text{meV}$, corresponding to a carrier concentration $\sim 2.2 \times 10^{12} \text{ cm}^{-2}$ by taking into account the dielectric constant $\sim 3[99]$ of Parylene and the residual



FIG. 5. (a) Raman spectra of SLG/PVK on fibre (green) and SLG/PVK on Si/SiO₂ (gray). (b) Backgrounds subtracted spectra from (a). (c) Raman spectra of fibre (red), fibre/dielectric (Al₂O₃ and parylene) (blue), fibre/dielectric/N_R=6 (orange), fibre/dielectric/N_R=6/PVK (green). The PL background of PVK is subtracted for the green spectrum. All spectra for 514.5nm.

Sample	$\underset{cm^{-1}}{Pos(G)}$	$FWHM(G)$ cm^{-1}	$\frac{\rm Pos(2D)}{\rm cm^{-1}}$	$_{\rm cm^{-1}}^{\rm FWHM(2D)}$	A(2D)/A(G)	I(2D)/I(G)	I(D)/I(G)	E_F meV	Doping type	Uniaxial strain%	Biaxial strain%	$\substack{ {\rm defect \ density} \\ \times 10^{11} {\rm cm}^{-2} }$
$N_R=6$	$\begin{array}{c} 1584 \\ \pm 1 \end{array}$	21 ± 2	$2694 \\ \pm 2$	38 ± 3	2.9 ± 1.5	$\begin{array}{c} 1.7 \\ \pm 0.9 \end{array}$	$\begin{array}{c} 0.10 \\ \pm 0.08 \end{array}$	$\begin{array}{c} 310 \\ \pm 110 \end{array}$	р	$\begin{array}{c} 0.40 \\ \pm 0.04 \end{array}$	$\begin{array}{c} 0.15 \\ \pm 0.02 \end{array}$	$\begin{array}{c} 0.49 \\ \pm 0.12 \end{array}$
$N_R=6$	$^{1587}_{\pm 1}$	17 ± 2	2686 ± 3	$41 \\ \pm 3$	4.7 ± 1	$\begin{array}{c} 1.9 \\ \pm 0.3 \end{array}$	$0.49 \\ \pm 0.1$	$\begin{array}{c} 190 \\ \pm 20 \end{array}$	р	-0.06 ± 0.06	-0.02 ± 0.02	1.82 ± 0.39
$N_R=6/PVK$	1583 ± 1	17 ± 2	$\begin{array}{c} 2701 \\ \pm 3 \end{array}$	$\begin{array}{c} 43 \\ \pm 3 \end{array}$	$\begin{array}{c} 2.3 \\ \pm 0.6 \end{array}$	$\begin{array}{c} 0.9 \\ \pm 0.3 \end{array}$	$\begin{array}{c} 0.46 \\ \pm 0.1 \end{array}$	$\begin{array}{c} 380 \\ \pm 30 \end{array}$	р	$\begin{array}{c} 0.60 \\ \pm 0.03 \end{array}$	$\begin{array}{c} 0.20 \\ \pm 0.01 \end{array}$	$\begin{array}{c} 2.48 \\ \pm 0.62 \end{array}$

TABLE II. Raman fit parameters, resulting Fermi energy (E_F) , doping type (n or p), strain, and defect density. The first row relates to rolled graphene layers on top of the fibre (gate), while the last two rows correspond to fibre with a dielectric layer (150nm Al₂O₃ and 200nm parylene C) (channel).



FIG. 6. (a) SEM and (b) AFM image of PVK film on $N_R=6$, inset image shows the roughness of spin-coated PVK film. (c-e) Optical microscopy images of final device. (d,e) Source-drain and gate electrodes, respectively, printed using Ag ink. s, d, g indicate source, drain, gate, respectively

PMMA from transfer of CVD SLG[80]. I(D)/I(G)~0.49 corresponds to a defect density~ 1.82×10^{11} cm⁻²[81, 82] for 2.41eV excitation and $E_F \sim 190$ meV. The doping level as calculated from A(2D)/A(G) should correspond to Pos(G)~1586cm⁻¹ for unstrained graphene[79]. However, in our experiment Pos(G)~1587cm⁻¹, which implies a contribution from compressive uniaxial (biaxial) strain~0.06% (0.02%)[84]. Table 2 summarizes the Raman fit parameters and the resulting E_F , doping, strain, and defect density.

Source and drain electrodes are defined (channel length: 1000 μ m; diameter: 125 μ m) by inkjet printing Ag ink (Sigma-Aldrich, 736465) (resistivity=11 μ \Omegacm). Ag ink is also printed on the gate, and the ink is cured on a hot plate at 150°C for 1h to remove the residual solvent (triethylene glycol monomethyl ether). We use a Fujifilm Dimatix DMP-2800 with a 21 μ m diameter nozzle. This approach removes the need for conventional lithography[100], or shadow masks[101].

Then, a mixed-cation lead mixed-halide PVK[60] is prepared by dissolving PbI₂ (1.2M), formamidinium iodide (1.11M), methylammonium bromide (0.21M) and $PbBr_2$ (0.21M) in a mixture of anhydrous DMF:DMSO (4:1 volume ratio) followed by 5 vol% CsI stock solution (1.5M in DMSO). The final solution is diluted by adding 50 vol% DMF:DMSO (4:1 volume ratio). The PVK solutions is spin-coated (Fig.4e) on the surface-treated rolled SLG surface (10min under UV ozone utilising UV-Ozone Cleaner UVC-1014, in order to facilitate the dispersion of PVK, by making the surface hydrophilic[102]) using a two-step speed program at 2000 and 6000rpm for 10 and 30s, respectively, adding 150μ l of chlorobenzene 30s after the start of the spinning routine [103]. These different speeds allow us to get more homogeneity with respect to one-step spinning[103], and remove solvents during the PVK film formation[103]. The samples are annealed at 100°C for 1h to remove the solvents (Dimethylformamide and Dimethyl sulfoxide)[103]. All processes to make and spin coat PVK are performed in a N₂-filled glove box to prevent degradation of PVK triggered by $H_2O[104]$.

Fig.5a plots the Raman spectra of SLG/PVK on fibre (green) and Si/SiO₂ (gray) for 514.5nm excitation. These show three bands~52, 110, 249 cm^{-1} . The PL background of PVK can be seen in Fig.5a and back-

ground subtracted spectra are in Fig.5b. The bands \sim 52 and $110cm^{-1}$ are the main modes of PVK[105] assigned to $PbBr_6$ deformation[106, 107] and motion of the organic cation [106, 107], respectively. The peak $\sim 249 cm^{-1}$ is assigned to torsional mode of the methylammonium cation, due to PVK exposure to moisture[105, 108]. Moisture could be introduced when the sample is removed from the glove-box, prior to sealing with parylene. After the deposition of PVK on $N_R=6$, Fig.4e, the Raman spectrum of $N_B=6$ has $Pos(G) \sim 1583 cm^{-1}$, $FWHM(G) \sim 17 cm^{-1}$, $Pos(2D) \sim 2701 cm^{-1}$, $FWHM(2D) \sim 43 cm^{-1}$. $I(2D)/I(G) \sim 0.9$ and $A(2D)/A(G) \sim 2.3.$ $Pos(2D) \sim 2701 cm^{-1}$ indicates From $A(2D)/A(G) \sim 2.3$ we p-doping[80]. estimate $E_F \sim 380 \text{meV}$, which corresponds to a carrier concentration $\sim 8.8 \times 10^{12} \text{cm}^{-2}$, by taking into account the dielectric constant of Parylene and residual PMMA[80]. $I(D)/I(G) \sim 0.46$ corresponds to a defect density~ 2.5×10^{11} cm⁻²[81, 82] for 2.41eV excitation and $E_F \sim 380 \text{meV}$. E_F as estimated from A(2D)/A(G) should correspond to $Pos(G) \sim 1596 \text{ cm}^{-1}$ for unstrained graphene^[79]. However, in our experiment $Pos(G) \sim 1583 cm^{-1}$, which implies tensile uniaxial (biaxial) strain $\sim 0.6\% (0.2\%)$ [84].

Fig.6a is a SEM image of the spin-coated PVK on $N_R=6$. This shows uniform coverage. An average roughness~20nm is measured with a Bruker Dimension Icon atomic force microscope (AFM) in Fig.6b. Figs.6c-e are optical images of the final device.

Fig.7a plots the absorbance from photo-thermal deflection spectroscopy (PDS) of individual SLG and PVK films on quartz, compared with SLG/PVK. A combination of a Light Support MKII 100 W Xe arc source and a CVI DK240 monochromator is used to produce a modulated monochromated light beam. The probe beam comes from a Qioptiq 670nm fibre-coupled diode laser directed parallel to the PVK film surface. PDS can measure the band-tails of PVK down to $\sim 10^{-5}$ absorbance[109]. Fig.7a shows that PVK absorption increases for SLG/PVK compared to PVK. This indicates the presence of interface states that alter the PVK bandgap[109]. The PL spectra of PVK and SLG/PVK are in Fig.7b. Both show a PL peak~762nm arising from the PVK band gap[60]. The PL intensity (integrated area under PL curve) of SLG/PVK is quenched $\sim 96\%$ compared to PVK. This can be assigned to charge carrier transfer between PVK and SLG[110], though there is also increased non-radiative recombination due to the increased sub-gap trap density, as shown by the PDS measurements in Fig.7a. Time-resolved PL (TRPL) spectra are recorded at RT with a gated intensified CCD camera (Andor iStar DH740 CCI-010) connected to an Andor SR303i spectrometer with time resolution~0.1ns. A Ti:sapphire optical amplifier (1kHz, 90fs pulse width) is used to generate narrow bandwidth photoexcitation (FWHM=10nm at 400nm) via a non-



FIG. 7. (a) Absorbance of PVK and SLG/PVK. (b) PL of PVK and SLG/PVK for 514.5nm excitation. (c) TRPL spectra of PVK and SLG/PVK for 400nm excitation. The arrow indicates a shorter lifetime.



FIG. 8. (a) I_{ds} as a function of V_{ds} in the dark before (red) and after (blue) deposition of PVK on $N_R=6$. (b) Transconductance for $V_{ds}=0.5V$ for $N_R=6$ in dark. (c) Illumination power-dependent transfer characteristics at 488nm. (d) Photocurrent as a function of bias for different illumination power and $V_g=0$. (e) R_{ext} as a function of optical power density. (f) Temporal photocurrent response for $N_R=6$ under alternating dark (purple) and light (yellow).

collinear optical parametric amplifier and a pulse fluence of 0.5μ Jcm⁻². We thus fit Fig.7c to calculate average lifetimes as a means to compare the amount of charge quenching, but we do not imply any physical meaning to this fit. We use the relation[35]:

$$f(t) = \sum_{i} A_i exp(-t/\tau_i) + B \tag{3}$$

where A_i is decay amplitude, τ_i is decay time and B is constant. The PL decay times for PVK are τ_1 =6.7ns (A₁:0.802) and τ_2 =32.9ns (A₂:0.198) with average lifetime ($\Sigma A_i \tau_i$)/(ΣA_i) of 11.8ns. The PL decay times for SLG/PVK are τ_1 =2.0ns (A₁:0.743) and τ_2 =10.7ns (A₂:0.257) with average lifetime~4.3ns, indicating charge transfer between SLG and PVK[111], because of band energy alignment at the PVK/SLG interface.

We then characterize the photoresponse of the fibrebased PDs. The linear dependence of current vs voltage in Fig.8a indicates Ohmic contact of CVD SLG and Ag electrodes. By depositing PVK, the current increases in Figs.8a,b, suggesting h transfer from PVK to SLG, in agreement with the Raman measurement in Fig.5. A similar h transfer was previously reported for SLG/PVK interfaces[112, 113]. The field-effect μ is calculated as[33]:

$$\mu = \frac{\triangle I_d.L}{\triangle V_g.C_{ox}.V_{ds}.2\pi r} \tag{4}$$

Fig.8c plots I_{ds} vs V_q when the PD is illuminated at 488nm for normal incidence with a collimated laser (Multi-Channel Source-Thorlabs) with $P=44\mu W$ to 2nWfor $V_{ds} \sim 0.5 V$. -2< $V_g < +10$ is used as a safe range to avoid dielectric breakdown. The gate-source current is kept<1nA to avoid leakage. Due to the ultrafast (sub-100fs) charge recombination in SLG[115], the photogenerated carriers do not contribute to the photocurrent. A gate-dependent photocurrent is not observed in our channel, Fig.8c. This could be explained by the screening of the electric field by the SLG layers underneath[116]. Under illumination, light is absorbed by PVK and part of the photogenerated h are transferred from the PVK valence band into the lower energy states in p-doped SLG[112, 113], leaving behind the uncompensated charge of photogenerated e[112, 113]. The latter are trapped in PVK and act as an additional negative gate voltage, applied to the SLG channel, altering the electric field at the SLG/PVK junction[112, 113]. The photocurrent is[33]:

$$\triangle I_{ph} = I_{light} - I_{dark} \tag{5}$$

where I_{light} is the output current of the device under the incident beam, and I_{dark} is the current measured in dark. The photocurrent of the fibre-based SLG/PVK PDs is in Fig.8d, for P ranging from 980 μ W to 750pW, and V_{ds} from -1 to 1V. The corresponding R_{ext} as a function of power density is in Fig.8e. For A_{PD} and A₀ ~0.18 μ m² and 0.785 μ m², respectively, we get R_{ext} ~22,000A/W



FIG. 9. (a) Spectral noise power of fibre PDs. (b) Wavelength dependent R_{ext} for PDs and absorption of fibre PDs from the KK relations as a function of excitation wavelength

for P=750pW and $V_{ds}=1V$. For $V_{ds} >1$, the free carriers drift velocity ν_d in SLG increases lineally until saturation by scattering with optical phonons[117]. Therefore, all measurements are done at $V_{ds} \leq 1V$ to keep the device operation in the linear (Ohmic) regime. A P rise leads to higher photocurrents until saturation $(44\mu W \text{ and } 980\mu W)$, due to the increased recombination rate of photo excited carriers [113]. This R_{ext} is seven orders of magnitude higher than the~mA/W reported for SLG on flat and rigid substrates (e.g. Si/SiO_2 [68, 118–120], one order of magnitude higher than reported for PVK on $Si/SiO_2[57]$, and four orders of magnitudes higher than pristine PVK~3A/W[121] on flexible PET substrates. Our R_{ext} is two orders of magnitude higher than PVK/SLG hybrid PDs on $Si/SiO_2[112]$, but lower than the highest $R_{ext} \sim 10^9 A/W$ PDs based on PVK/organic-semiconductor(poly-(3,4ethylenedioxythiophene):poly(styrenesulfonate))[122] and lower than hybrid SLG/QDs[67] and SLG/MoS_2

PDs[123], both with $R_{ext} \sim 10^7 A/W$ on Si/SiO₂, see

Table 1. However, our R_{ext} is the highest amongst fibre-based PDs for wearable applications, table I.

The temporal photocurrent response is measured in Fig.8f via an digital oscilloscope (MSO9404A). This gives a rise time~5ms and a fall time~35ms, faster than the~200ms reported for carbon fibre/PVK PDs[32] and~40ms for fibre based P3HT/ZnO PDs[36], and comparable to PDs made of mechanically exfoliated SLG and QDs on Si/SiO₂[67].

The specific detectivity (D^{*}) ($(cm.Hz^{1/2}/W)$ or Jones) relates the performance of PDs in terms of R_{ext} to the PD photoactive area, allowing the comparison of PDs with different active areas[33]:

$$D^* = \frac{(AB)^{1/2}}{NEP}$$
(6)

where A is the photoactive area (projected incident light on fibre), B is the electrical bandwidth (Hz) and $\text{NEP}(W/Hz^{1/2})$ is the noise equivalent power (the power that gives a signal-to-noise ratio of one in a 1Hz output bandwidth) defined as[126]:

$$NEP = \frac{i_n}{R_{ext}} \tag{7}$$

where i_n is the dark noise current. The fibre PD is DC biased with a source meter (Keithley 2612B). A chopper is used in the path of the incident beam to modulate the light[126]. The noise (A/\sqrt{Hz}) is characterized in the time domain collecting the trace on a digital oscilloscope, with subsequent Fourier transform to analyze the data in the spectral domain.

Fig.9a plots the spectral noise density as a function of frequency f. The measured noise in the dark shows a 1/fdependence. Thus, the noise density (i.e. noise power per unit of bandwidth $(dbm.Hz^{-1/2}))[33]$ is inversely proportional to f, due to charge traps and defects [33]. Considering the measurement at $4Hz, \sim 10$ times less than the cut off f, defined as the f at which the detector \mathbf{R}_{ext} decreases by 3dB[33], we get NEP $\sim 2.1 \times 10^{-11}$ W/Hz^{1/2}. $D^* \sim 2 \times 10^9$ Jones for N_B=6. The noise current in the shot noise limit (due to generation and recombination of e-h pairs and resistive current paths in PDs[6], can be expressed as $i_n = (2qI_{dark})^{1/2}[126, 127]$, where the combined dark current (I_{dark}) is the sum of unamplified graphene current $(I_{dark(SLG)})$ and amplified injection current $(I_{dark(PVK)})$ from PVK, caused by the thermal excitations of charge carriers in the dark. $I_{dark(PVK)}$, which is due to thermal excitations of charge carriers in the dark, is much smaller than $I_{dark(SLG)} \sim 3.75$ mA. Therefore, following Ref. [127], the shot noise limited noise current can be expressed as $i_n = (2qI_{dark(SLG)})^{1/2}$. D^* in the shot noise limit can be written as [126]:

$$D^* = \frac{R_{ext}(AB)^{1/2}}{i_n}$$
(8)



FIG. 10. (a) $I_{ph,bend}/I_{ph,nobend}$ for $N_R=6$ as a function of R_b . (b) $I_{ph,bend}/I_{ph,nobend}$ for $N_R=6$ as a function of bending cycles for $R_b=4$ mm. (c) $I_{ph,wash}/I_{ph,nowash}$ for $N_R=6$ as a function of AATCC washing cycles.

We get D^{*} ~10¹³ Jones for N_R=6. Our D^{*} is comparable with that of state-of-the-art fiber based PDs[32], where D^{*} ~ 2.15 × 10¹³ Jones, but with R_{ext} ~562.9mA/W at 800nm and τ_{res} ~200ms[32], see Table 1.

Fig.9b plots R_{ext} as a function of wavelength from 490 up 870nm. This follows the absorption of SLG/PVK films, Fig.7a, suggesting PVK is the main light absorbing layer in which photoexcited charges are supplied [56]. To get a better understanding of the spectral response of PDs versus wavelength, optical simulations are performed by extracting the PVK index from Ref. [128]. We use the PVK refractive index in transfer matrix calculations to estimate the absorption of SLG/PVK on our fibre structure. The imaginary and the real part of the PVK average index is found by applying the Kramers-Kronig (KK) relation, $n_{PVK}(w) = 1 + 2\pi^{-1}$ $\mathcal{P} \int_0^\infty w' K_{PVK}(w')/(w'^2 - w^2) dw'$, where \mathcal{P} denotes the principal value of the integral and w is the angular f. The SLG refractive index is modelled by the Kubo conductance [129] at RT and $E_F = 380$ meV. The spectral response of the fibre PDs in Fig.9b follows the optical absorption of SLG/PVK on fibre in Fig.9b, i.e. drop of \mathbf{R}_{ext} and absorption with increasing wavelength.

Mechanical characterizations are crucial to emulate real-life applications of wearable PDs[26]. These include washing in a tumble washing machine[6, 130] and deformations against body motions (such as bending[6]). We thus test our fibre-based PDs according to AATCC[10] for washing. For mechanical deformations, we perform bending cycles, starting from a radius of curvature of 55mm where the PDs show almost no performance change, to 1mm where we observe PD degradation.

Fig.10b is the schematic of a three-point bending setup (Deben Microtest) we use to characterize the effect of bending on the PD photocurrent. The photocurrent is first measured for no bending $(I_{ph,nobend})$, and then under bending $(I_{ph,bend})$. We use the ratio of $(I_{ph,bend})$ over $(I_{ph,nobend})$ to monitor the effect of mechanical deformations. The bending radius (R_b) is calculated as[131]:

$$R_b = \frac{[H^2 + (L/2)^2]}{2H} \tag{9}$$

where H is the height at the chord midpoint of two ends of the arc, and L is the chord of circumference connecting two ends of the arc.

Fig. 10 plots average and standard deviations (error bars) of $I_{ph,bend}/I_{ph,nobend}$ as a function of R_b and bending cycles, as well as $I_{ph,wash}/I_{ph,nowash}$ as a function of washing cycles. $I_{ph,bend}/I_{ph,nobend}$ shows up to~20% variation for bending radius as low as 4mm (R_b =4mm), Fig.10a. Fig.10 suggests that variations primarily occur during the initial cycles. Refs.[132–134] reported that the electrical behaviour of SLG on flexible substrates (e.g. PET, PDMS) stabilizes after several deformations. Ref.[135] reported that the morphology of SLG wrinkles undergoes gradual modification with increasing bending, leading to a change of contact area. We attribute the slight increase of $I_{ph,bend}/I_{ph,nobend}$ up to $R_b \sim 4mm$ to changes in contact area of rolled CVD SLG on PVK. Upon further bending ($R_b < 4mm$), $I_{ph,bend}$ drops to~10% of $I_{ph,nobend}$, due to failure of various components, such as contact of Ag electrodes with graphene and crack formation in the fibre PD. Despite pushing our PDs to much lower R_b (4mm) compared to InP-based semiconductor flexible PDs $(R_b > 38.1 \text{mm})[136]$, we achieve five orders of magnitude higher R_{ext} (22,000A/W here vs 0.12A/W at 533nm[136]), Table 1. Ref.[137] reported hybrid CVD SLG and PVK on Polyimide with $R_b = 12 \text{mm}[137]$, one order of magnitude lower $R_{ext} = 115 A/W$ at 515 nm[137] compared to ours. Ref.[138] fabricated PVK/Conjugated-Polymer composite PDs on PET with comparable R_b ($R_b = 4mm$), yet, the latter has six orders of magnitude lower $R_{ext} \sim 154 \text{mA/W}$ at 835 nm[138], see Table 1.

We then test our devices for a fixed $R_b=4mm$ (as we observe~20% variation in $I_{ph,bend}/I_{ph,nobend}$ upto $R_b=4mm$ in Fig.10a) as a function of bending cycles, Fig.10b. After 100 bending cycles $(I_{ph,bend})/I_{ph,nobend}$ changes<20%, Fig.10b. In similar conditions, Ref.[32] reported 6 fold lower $R_{ext} \sim 560 \text{mA/W}$ at 800nm[32] for 60 less cycles, see Table 1.

We then test the PDs in a tumble washing machine (SKYLINE rotate washing color) at 40°C up to 30 washing cycles, each programmed for 45min, total volume $\sim 0.37\%$ (Persil detergent powder), and with ten 6mm stainless steel balls[10]. Two encapsulation approaches are used to protect the PDs during washing. The fibres are conformally coated with $\sim 1 \mu m$ parylene C, since this acts as a barrier to moisture [139] and gases [139]. The PDs are then further coated with PDMS for additional waterproofing and resistance against tension/compression introduced during washing. Part A and B of the commercial Si-based elastomer Polycraft T15 are mixed 1:1 using a speed mixer (DAC 150 FVZ-K) at 2000rpm for 30s. The resulting solution is then spread on the fibre and cured at 80°C for 30min to expedite the process and ensure crosslinking of polymer chains [140]. After encapsulation, the devices are tested at 488nm at 1V. They have $R_{ext} \sim 22,000 \text{A/W}$, with no degradation after encapsulation. The photocurrent of fibre-based PDs is first measured for no washing step $(I_{ph,nowash})$. The PDs are then placed in a tumble washing machine and washed. The PDs are then drip dried in a ventilated oven at 60°C (Genlab Air), then measured at various washing cycles $(I_{ph,wash})$ from 1 to 30 cycles, Fig.10c. After 20 cycles, the PDs show~6% degradation in $I_{ph,wash}/I_{ph,nowash}$, Fig.10c. After 30 washing cycles, I_{ph,wash}/I_{ph,nowash} drops $\sim 28\%$, due to degradation of electrodes caused by stresses during washing. Ref. [71] reported $\sim 50\%$ drop in drain current after 10 and 20 washing cycles, however, our fibre PDs maintained up to $\sim 72\%$ of the I_{ph} after 30 washing cycles.

CONCLUSIONS

We reported fibre-based SLG/PVK PDs with R_{ext} up to~22,000A/W at 1V operating voltage at 488nm. The PDs have a broad spectral responsivity between 488 and 870nm, with rise and fall times~5ms and~35ms. The devices were subjected to mechanical bending tests (100 cycles at $R_b \sim 4$ mm) with $I_{ph,bend}/I_{ph,nobend}$ changes<10% and washing tests (AATCC standard) with $I_{ph,wash}/I_{ph,nowash} \sim 94\%$ and~72% at 20 and 30 cycles, respectively. The combination of high (~22KA/W) responsivity, response time, flexibility, washability, and low (<1V) operating voltage make our PDs attractive for wearable applications.

ACKNOWLEDGMENTS

We acknowledge funding from EU Graphene Flagship, ERC Grants Hetero2D, GIPT, EU Grants CHARM, Graph-X, GreenCAP, EPSRC Grants EP/K01711X/1, EP/K017144/1, EP/N010345/1, and EP/L016087/1, EP/X015742/1, EP/V000055/1, the Royal Society and Tata Group (UF150033).For open access, we applied a Creative Commons Attribution (CC BY) license to any Author Accepted Manuscript version arising from this submission.

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- Y. Khan, A. E. Ostfeld, C. M. Lochner, A. Pierre, and A. C. Arias, Adv. Mater. 28, 4373 (2016).
- [2] M. K. Choi, J. Yang, K. Kang, D. C. Kim, C. Choi, C. Park, S. J. Kim, S. I. Chae, T. Kim, J. H. Kim *et al.*, Nat. Commun. **6**, 7149 (2015).
- [3] J. Wang, X. Li, Y. Zi, S. Wang, Z. Li, L. Zheng, F. Yi, S. Li, and Z. L. Wang, Adv. Mater. 27, 4830 (2015).
- [4] A. Nathan, A. Ahnood, M. T. Cole, S. Lee, Y. Suzuki, P. Hiralal, F. Bonaccorso, T. Hasan, L. Garcia-Gancedo, A. Dyadyusha, et al., Proc. IEEE **100**, 1486 (2012).
- [5] L. Hu, M. Pasta, F. L. Mantia, L. Cui, S. Jeong, H. D. Deshazer, J. W. Choi, S. M. Han, and Y. Cui, Nano Lett. 10, 708 (2010).
- [6] W. Zeng, L. Shu, Q. Li, S. Chen, F. Wang, and X. Tao, Adv. Mater. 26, 5310 (2014).
- [7] A. M. Grancaric´, I. Jerkovic´, V. Koncar, C. Cochrane, F. M. Kelly, D. Soulat, and X. Legrand, J. Ind. Text.48, 612 (2018).
- [8] M. Lou, I. Abdalla, M. Zhu, X. Wei, J. Yu, Z. Li, and B. Ding, ACS Appl Mater Interfaces12, 19965-

- [9] S. Rotzler, M. Krshiwoblozki, and M. Schneider-Ramelow, Text. Res. J. 91, 2401-2417 (2021).
- [10] AATCC Testing Method, American Association of Textile Chemists and Colourists Technical Manual, USA, 2004.
- [11] N. Karim, S. Afroj, S. Tan, P. He, A. Fernando, C. Carr, and K. S. Novoselov, ACS Nano 11, 12266 (2017).
- [12] I. G. Klepp, M. Buck, K. Laitala, M. Kjeldsberg, Fash. Pract.8, 296-317 (2016).
- [13] J. McCann and D. BrysonSmart clothes and wearable technology(Elsevier, 2009).
- [14] S. Gupta, W. T. Navaraj, L. Lorenzelli, and R.Dahiya, npj Flex2, 8 (2018).
- [15] M. Rein, V. D. Favrod, C. Hou, T. Khudiyev, A. Stolyarov, J. Cox, C. Chung, C. Chhav, M. Ellis, J. Joannopoulos et al., Nature 560, 214 (2018).
- [16] W. Gao, S. Emaminejad, H. Y. Y. Nyein, S. Challa, K. Chen, A. Peck, H. M. Fahad, H. Ota, H. Shiraki, D. Kiriya *et al.*, Nature **529**, 509 (2016).
- [17] E. O. Polat, G. Mercier, I. Nikitskiy, E. Puma1, T. Galan, S. Gupta1, M. Montagut, J. J. Piqueras, M. Bouwens, T. Durduran, et al., Sci. Adv. 5, eaaw7846 (2019).
- [18] M. Stoppa and A. Chiolerio, J. Sens 14, 11957 (2014).
- [19] M. Tilli, M. Paulasto-Kröckel, M. Petzold, H. Theuss, T. Motooka, V. Lindroos, *Handbook of silicon based MEMS materials and technologies* (Elsevier, New York, 2020).
- [20] A. S. Sedra, and K. C. Smith, *Microelectronic circuits* (Oxford University Press, New York, 1998).
- [21] G. Wang, C. Hou, and H. WangFlexible and Wearable Electronics for Smart Clothing(John Wiley and Sons, 2020).
- [22] D. Son, J. Lee, S. Qiao, R. Ghaffari, J. Kim, J. E. Lee, C. Song, S. J. Kim, D. J. Lee, S. W. Jun *et al.*, Nat. Nanotechnol. 9, 397 (2014).
- [23] R. Li, X. Xiang, X. Tong, J. Zou, and Q. Li, Adv. Mat. 27, 3831 (2015).
- [24] B. Dong, J. Hu, X. Xiao, S. Tang, X. Gao, Z. Peng, and D. Zou, Adv. Mat. Technol. 4, 1900131 (2019).
- [25] S. Kwon, H. Kim, S. Choi, E. G. Jeong, D. Kim, S. Lee, H. S. Lee, Y. C. Seo, and K. C. Choi, Nano Lett. 18, 347 (2018).
- [26] S. Cai, X. Xu, W. Yang, J. Chen, and X. Fang, Adv. Mater. **31**, 1808138 (2019).
- [27] J. Allen, Physiol. Meas. 28, R1 (2007).
- [28] X. Xu, J. Chen, S. Cai, Z. Long, Y. Zhang, L. Su, S. He, C. Tang, P. Liu, H. Peng, and X. Fang, Adv. Mater. **30**, 1803165 (2018).
- [29] J. hui Chen, Q. Jing, F. Xu, Z. da Lu, and Y. qing Lu, Optica 4, 835 (2017).
- [30] J. Chen, Z. Liang, L. Yuan, C. Li, M. Chen, Y. Xia, X. Zhang, F. Xu, and Y. Lu, Nanoscale 9, 3424 (2017).
- [31] F. Zhang, S. Niu, W. Guo, G. Zhu, Y. Liu, X. Zhang, and Z. L. Wang, ACS Nano 7, 4537 (2013).
- [32] H. Sun, W. Tian, F. Cao, J. Xiong, and L. Li, Adv. Mater. **30**, 1706986 (2018).
- [33] S. M. Sze, K. K. Ng, *Physics of semiconductor devices*, John Wiley and Sons (2006).
- [34] F. H. L. Koppens, T. Mueller, P. Avouris, A. C. Ferrari, M. S. Vitiello, and M. Polini, Nat. Nanotechnol. 9, 780 (2014).

- [35] B. E. A. Saleh, M. C. Teich, Fundamentals of photonics, New Jersey, John Wiley and Sons (2019).
- [36] X. Du, W. Tian, J. Pan, B. Hui, J. Sun, K. Zhang, Y. Xia, Nano Energy 92, 106694 (2022).
- [37] S. Afroj, S. Tan, A. M. Abdelkader, K. S. Novoselov, N. Karim, Adv. Func. Mater.30, 2000293 (2020).
- [38] H. Jinno, K. Fukuda, X. Xu, S. Park, Y. Suzuki, M. Koizumi, T. Yokota, I. Osaka, K. Takimiya, and T. Someya, Nat. Energy2, 780-785 (2017).
- [39] L. Wang, X. Fu, J. He, X. Shi, T. Chen, P. Chen, B. Wang, H. Peng, Adv. Mater.32, 1901971 (2020).
- [40] A. Satharasinghe, T. Hughes-Riley, and T. Dias, Sci. Rep.8, 1-13 (2018).
- [41] A. C. Ferrari, F. Bonaccorso, V. Fal'ko, K. S. Novoselov, S. Roche, P Bøggild, S. Borini, F. H. L. Koppens, V. Palermo, et al. Nanoscale 7, 4598 (2015).
- [42] F. Bonaccorso, Z. Sun, T. Hasan, and A. C. Ferrari, Nat. Photonics 4, 611 (2010).
- [43] J. Yoon, H. Sung, G. Lee, W. Cho, N. Ahn, H. S. Jung, and M. Choi, Energy Environ. Sci 10, 337 (2017).
- [44] A. Zanetta et al., Appl. Phys. Lett. 105 (2014).
- [45] V. Sorianello, M. Midrio, G. Contestabile, I. Asselberghs, J. Van Campenhout, C. Huyghebaert, I. Goykhman, A. K. Ott, A. C. Ferrari, and M. Romagnoli, Nat. Photonics **12**, 40 (2018).
- [46] M. Romagnoli, V. Sorianello, M. Midrio, F. H. L. Koppens, C. Huyghebaert, D. Neumaier, P. Galli, W. Templ, A. D'Errico, and A. C. Ferrari, Nat. Rev. Mater. 3, 392 (2018).
- [47] A. Tyagi et al., Nanoscale14, 2167-2176 (2022).
- [48] A. Giambra, V. Miseikis, S. Pezzini, S. Marconi, A. Montanaro, F. Fabbri, V. Sorianello, A. C. Ferrari, C. Coletti and M. Romagnoli, ACS nano15, 3171-3187 (2021).
- [49] C Backes at al., 2D Mater.7, 022001 (2020).
- [50] M. Khan, K. Indykiewicz, P. L. Tam, A. Yurgens, Nanomaterials12, 331 (2022).
- [51] S. D. Stranks, G. E. Eperon1, G. Grancini, C. Menelaou, M. J. P. Alcocer, T. Leijtens, L. M. Herz, A. Petrozza, H. J. Snaith, Science **342**, 3341 (2013).
- [52] S. De Wolf, J. Holovsky, S-J. Moon, P. Löper, B. Niesen, M. Ledinsky, F-J. Haug, J-H. Yum, C. Ballif, J. Phys. Chem. Lett. 5, 1035 (2014).
- [53] N. J. Jeon, J. H. Noh, W. S. Yang, Y. C. Kim, S. Ryu, J. Seo, and S. I. Seok, Nature **517**, 476 (2015).
- [54] J. Xing, Y. Zhao, M. Askerka, L. N. Quan, X. Gong, W. Zhao, J. Zhao, H. Tan, G. Long, L. Gao, Z. Yang, O. Voznyy, J. Tang, Z-H. Lu, Q. Xiong, and E. H. Sargent, Nat. Commun. 9, 1 (2018).
- [55] D. P. McMeekin, G. Sadoughi, W. Rehman, G. E. Eperon, M. Saliba, M. T. Hörantner, A. Haghighirad, N. Sakai, L. Korte, B. Rech, M. B. Johnston, L. M. Herz, H. J. Snaith, Science **351**, 151 (2016).
- [56] L. Dou, Y. Yang, J. You, Z. Hong, W-H. Chang, G. Li, and Y. Yang, Nat. Commun. 5, 5404 (2014).
- [57] F. Li, C. Ma, H. Wang, W. Hu, W. Yu, A. D. Sheikh, and T. Wu, Nat. Commun. 6, 8238 (2015).
- [58] C. Li, H. Wang, F. Wang, T. Li, M. Xu, H. Wang, Z. Wang, X. Zhan, W. Hu, and L. Shen, Light Sci. Appl.9, 1 (2020).
- [59] W. Wang, D. Zhao, F. Zhang, L. Li, M. Du, C. Wang, Y. Yu, Q. Huang, M. Zhang, L. Li, J. Miao, Z. Lou, G. Shen, Y. Fang, and Y. Yan, Adv. Funct. Mater27, 1703953 (2017).

- [60] M. Abdi-Jalebi, Z. Andaji-Garmaroudi, S. Cacovich, C. Stavrakas, B. Philippe, J. M. Richter, M. Alsari, E. P.Booker, E. M. Hutter, A. J. Pearson *et al.*, Nature 555, 497 (2018).
- [61] F. P. G. de Arquer, A. Armin, P. Meredith, and E. H. Sargent, Nat. Rev. Mater, 2, 16100 (2017).
- [62] T. M. Brenner, D. A. Egger, L. Kronik, G. Hodes, and D. Cahen, Nat. Rev. Mater, 1, 15007 (2016).
- [63] Ji-Hyuk Choi, H. Wang, S. Ju Oh, T. Paik, P. S. Jo, J. Sung, X. Ye, T. Zhao, B. T. Diroll, C. B. Murray, C. R. Kagan, Nat. Rev. Mater., **352**, 205 (2016).
- [64] L. Lin, J. Zhang, H. Su, J. Li, L. Sun, Z. Wang, F. Xu, C. Liu, S. Lopatin, Y. Zhu, K. Jia, S. Chen, D. Rui, J. Sun, R. Xue, P. Gao, N. Kang, Y. Han, Nat. Commun. 10, 1 (2019).
- [65] D. De Fazio, D. G. Purdie, A. K. Ott, P. Braeuninger-Weimer, T. Khodkov, S. Goossens, T. Taniguchi, K. Watanabe, P. Livreri, F. H. L. Koppens, S. Hofmann, I. Goykhman, A. C. Ferrari, A. Lombardo, ACS Nano 13, 8926 (2019).
- [66] R. R. Nair, P. Blake, A. N. Grigorenko, K. S. Novoselov, T. J. Booth, T. Stauber, N. M. R. Peres, and A. K. Geim, Science **320**, 5881 (2008).
- [67] G. Konstantatos, M. Badioli, L. Gaudreau, J. Osmond, M. Bernechea, F. P. G. De Arquer, F. Gatti, and F. H. Koppens, Nat. Nanotechnol. 7, 363 (2012).
- [68] F. Xia, T. Mueller, Y-M. Lin, A. Valdes-Garcia, and P. Avouris, Nat. Nanotechnol 4, 839 (2009).
- [69] M. Saliba, T. Matsui, J-Y. Seo, K. Domanski, J-P. Correa-Baena, M. K. Nazeeruddin, S. M. Zakeeruddin, W. Tress, A. Abate, A. Hagfeldt, and M. Grätzel, Energy Environ. Sci. 9, 1989 (2016).
- [70] E. M. Tennyson, B. Roose, J. L. Garrett, C. Gong, J. N. Munday, A. Abate, M. S. Leite, ACS Nano 13, 1538 (2018).
- [71] T. Carey, S. Cacovich, G. Divitini, J. Ren, A. Mansouri, J. M. Kim, C. Wang, C. Ducati, R. Sordan, and F. Torrisi, Nat. Commun. 8, 220 (2017).
- [72] S. Bae, H. Kim, Y. Lee, X. Xu, J. Park, Y. Zheng, J. Balakrishnan, T. Lei, H. R. Kim, Y. I. Song *et al.*, Nat. Nanotechnol. 5, 574 (2010).
- [73] F. Bonaccorso, A. Lombardo, T. Hasan, Z. Sun, L. Colombo, and A. C. Ferrari, Mater. Today 15, 564 (2012).
- [74] N. B. Babaroud et al., Microsyst. Nanoeng 8, 107 (2022).
- [75] K. Chatterjee, J. Tabor, and T. K. Ghosh Fibers 7, 51 (2019).
- [76] A. C. Ferrari, J. Meyer, V. Scardaci, C. Casiraghi, M. Lazzeri, F. Mauri, S. Piscanec, D. Jiang, K. Novoselov, S. Roth *et al.*, Phys. Rev. Lett. **97**, 187401 (2006).
- [77] A. C. Ferrari, and D. M. Basko, Nat. Nanotechnol. 8, 235 (2013).
- [78] A. C. Ferrari, Solid State Commun., 143, 47 (2007).
- [79] A. Das, S. Pisana, B. Chakraborty, S. Piscanec, S. K. Saha, U. V. Waghmare, K. S. Novoselov, H. R. Krishnamurthy, A. K. Geim, A. C. Ferrari, and A. K. Sood, Nat. Nanotechnol., 3, 210 (2008).
- [80] D. M. Basko, S. Piscanec, and A. C. Ferrari, Phys. Rev. B, 80, 165413 (2009).
- [81] L. G. Cançado, A. Jorio, E. H. M. Ferreira, F. Stavale, C. A. Achete, R. B. Capaz, M. V. O. Moutinho, A. Lombardo, T. S. Kulmala, and A. C. Ferrari, Nano Lett. 11, 3190 (2011).

- [82] M. Bruna, Anna K. Ott, M. Ijäs, D. Yoon, U. Sassi, and A. C. Ferrari, ACS Nano 8, 7432 (2014).
- [83] B. El-Kareh, L. N. Hutter*Fundamentals of semiconduc*tor processing technology(Springer Science & Business Media, 1995).
- [84] T. M. G. Mohiuddin, A. Lombardo, R. R. Nair, A. Bonetti, G. Savini, R. Jalil, N. Bonini, D. M. Basko, C. Galiotis, N. Marzari, K. S. Novoselov, A. K. Geim, and A. C. Ferrari, Phys. Rev. B79, 205433 (2009).
- [85] D. Yoon, Y-W. Son, and H. Cheong, Phys. Rev. Lett. 106, 155502 (2011).
- [86] B. Fallahazad, K. Lee, G. Lian, S. Kim, C. M. Corbet, D. A. Ferrer, L. Colombo, and E. Tutuc, Appl. Phys. Lett., 100, 093112 (2012).
- [87] T. Gupta Copper interconnect technology (Springer Science & Business Media, 2010).
- [88] S. Kim, J. Nah, I. Jo, D. Shahrjerdi, L. Colombo, Z. Yao; E. l Tutuc, S. K. Banerjee, Appl. Phys. Lett.,94. (2009).
- [89] A. Stassen, R. De Boer, N. Iosad, and A. Morpurgo, Appl. Phys. Lett. 85, 3899 (2004).
- [90] S. S. Sabri, P. L. Lévesque, C. M. Aguirre, J. Guillemette, R. Martel, and T. Szkopek, Appl. Phys. Lett., 95, 242104 (2009).
- [91] L-L. Chua, J. Zaumseil, J-F. Chang, E. C-W. Ou, P. K-H. Ho, H. Sirringhaus, and R. H. Friend, Nature 434, 194 (2005).
- [92] Z. Yin, M. Yin, Z. Liu, Y. Zhang, A. P. Zhang, and Q. Zheng, Adv. Sci. 5, 1701041 (2018).
- [93] T. Marszalek, M. Gazicki-Lipman, and J. Ulanski, Beilstein J. Nanotechnol. 8, 1532 (2017).
- [94] R. L. Puurunen, J. Appl. Phys., 97, 9 (2005).
- [95] J. D. Slinker, J. A. DeFranco, M. J. Jaquith, W. R. Silveira, Y-W. Zhong, J. M. Moran-Mirabal, H. G. Craighead, H. D. Abruña, J. A. Marohn, and G. G. Malliaras, Nat. Mater. 6, 894 (2007).
- [96] A. Kahouli, J. Appl. Phys. **112**, 064103 (2012).
- [97] M. S. Mathur and N. A. Weir, J. Mol. Struct15, 459 (1973).
- [98] J. Jakabovic, J. Kovacac, M. Weisb , D. Haskoc, R.Srnaneka, P. Valenta, R. Reseld, Microelectronics J.40, 595 (2009).
- [99] J. Mark, K. Ngai, W. Graessley, L. Mandelkern, E, Samulski, G. Wignall, J. Koenig *Physical properties of polymers* (Cambridge University Press, 2004).
- [100] L. W. Ng, G. Hu, R. C. Howe, X. Zhu, Z. Yang, C. Jones, and T. Hasan, *Printing of Graphene and Related* 2D Materials(Springer, 2019).
- [101] J. Plummer, M. D. Deal, and P. B. Griffin, Silicon VLSI technology: fundamentals, practice and modeling, Pearson Education India (2009).
- [102] X. Liu, Y. Cheng, C. Liu, T. Zhang, N. Zhang, S. Zhang, J. Chen, Q. Xu, J. Ouyang, and H. Gong, Energy Environ. Sci. 12, 1622 (2019).
- [103] N. J. Jeon, J. H. Noh, Y. C. Kim, W. S. Yang, S. Ryu, and S. I. Seok, Nat. Mater. 13, 897 (2014).
- [104] T. A. Berhe, W-N. Su, C-H. Chen, C-J. Pan, J-H. Cheng, H-M. Chen, M-C. Tsai, L-Y. Chen, A. A. Dubaleb, and B-J. Hwang, Energy Environ. Sci.9, 323 (2016).
- [105] M. Ledinsky, P. Loper, B. Niesen, J. Holovsky, S.-J.Moon, J.-H. Yum, S. De Wolf, A. Fejfar, and C. Bal-lif, J. Phys. Chem. Lett. 6, 401 (2015).

- [106] D. M. Calistru, L. Mihut, S. Lefrant, and I. Baltog, J. Appl. Phys. 82, 5391 (1997).
- [107] T. Dammak, N. Fourati, H. Boughzala, A. Mlayah, Y. Abid, J. Lumin. **127**, 404 (2007).
- [108] C. Quarti, G. Grancini, E. Mosconi, P. Bruno, J. M. Ball, M. M. Lee, H. J. Snaith, A. Petrozza, F. D. Angelis, J. Phys. Chem. Lett.5, 279 (2013).
- [109] M. Pazoki, A. Hagfeldt, and T. Edvinsson, Characterization Techniques for Perovskite Solar Cell Materials, Elsevier (2019).
- [110] Z. Zhu, J. Ma, Z. Wang, C. Mu, Z. Fan, L. Du, Y. Bai, L. Fan, H. Yan, D. L. Phillips *et al.*, J. Am. Chem. Soc. 136, 3760 (2014).
- [111] J. Li, S. Yuan, G. Tang, G. Li, D. Liu, J. Li, X. Hu, Y. Liu, J. Li, Z. Yang *et al.*, ACS Appl. Mater. Interfaces 9, 42779 (2017).
- [112] Y. Lee, J. Kwon, E. Hwang, C-H Ra, W. J. Yoo. J-H. Ahn, J. H. Park, and J. H. Cho, Adv. Mater., 27, 41 (2015).
- [113] Y. Wang, Y. Zhang, Y. Lu, W. Xu, H. Mu, C. Chen, H. Qiao, J. Song, S. Li, B. Sun *et al.*, Adv. Opt. Mater. 3, 1389 (2015).
- [114] V. Lucarini, J. J. Saarinen, K. E. Peiponen, E. M. Vartiainen, *Kramers-Kronig relations in optical materi*als research (Springer, 2005).
- [115] D. Brida, A. Tomadin, C. Manzoni, Y. J. Kim, A. Lombardo, S. Milana, R. R. Nair, K. S. Novoselov, A. C. Ferrari, G. Cerullo *et al.*, Nat. Commun. 4, 1987 (2013).
- [116] E. J. Santos, and E. Kaxiras, Nano Lett. 13, 898 (2013).
- [117] M. Lazzeri, S. Piscanec, F. Mauri, A. C. Ferrari, and J. Robertson, Phys. Rev. Lett.95, 236802 (2005).
- [118] T. Mueller, F. Xia, and P. Avouris, Nat. Photonics, 4, 297 (2010).
- [119] X. Gan, R-J. Shiue, Y. Gao, I. Meric, T. F. Heinz, K. Shepard, J. Hone, S. Assefa, and D. Englund, Nat. Photonics, 7, 883 (2013).
- [120] A. Pospischil, M. Humer, M. M. Furchi, D. Bachmann, R. Guider, T. Fromherz, and T. Mueller, Nat. Photonics, 7, 892 (2013).
- [121] X. Hu, X. Zhang, L. Liang, J. Bao, S. Li, W. Yang, and Y. Xie, Adv. Funct. Mater. 24, 7373 (2014).

- [122] C. Xie, P. You, Z. Liu, L. Li, and F. Yan, Light Sci. Appl 6, e17023 (2017).
- [123] W. Zhang, C-P. Chuu, J-K. Huang, C-H. Chen, M-L. Tsai, Y-H. Chang, C-T. Liang, Y-Z. Chen, Y-L. Chueh, J-H. He, M-Y. Chou, and L-J. Li, Sci. Rep4, 3826 (2014).
- [124] D. De Fazio, I. Goykhman, D. Yoon, M. Bruna, A. Eiden, S. Milana, U. Sassi, M. Barbone, D. Dumcenco, K. Marinov, A. Kis, and A. C. Ferrari, ACS Nano.10, 8252 (2016).
- [125] M. I. Saidaminov, M. A. Haque, M. Savoie, A. L. Abdelhady, N. Cho, I. Dursun, U. Buttner, E. Alarousu, T. Wu, O. M. Bakr, Adv. Mater., 28, 8144-8149 (2016).
- [126] Y. Fang, A. Armin, P. Meredith, and J. Huang, Nat. Photonics, 13, 1 (2019).
- [127] S. Bianconi, L. J. Lauhon, and H. Mohseni, Nat. Photonics, 15, 714 (2021).
- [128] A. Tejada, S. Peters, A. Al-Ashouri, S. H. Turren-Cruz, A. Abate, S. Albrecht, F. Ruske, B. Rech, J. A. Guerra, L. Korte, Adv. Opt. Mater 5, 2101553 (2021).
- [129] G. W. Hanson, J. Appl. Phys.44, 084314 (2008).
- [130] C. Mattmann, F. Clemens, and G. Tröster, Sensors, 8, 3719 (2008).
- [131] J. W. S. Hearle, P. Grosberg, and Stanley Backer, Structural mechanics of fibers, yarns, and fabrics, Wiley-Interscience (1969).
- [132] Y. Qiao et al. ACS Nano **12**, 8839 (2018)
- [133] F. Pan et al. Adv. Funct. Mater. 4, 1803211 (2018)
- [134] Z. Yang et al. ACS Nano **12**, 9134 (2018)
- [135] P.D. Qi et al. ACS Appl. Mater. Interf. 12, 23272 (2020)
- [136] W. Yang, H. Yang, G. Qin, Z. Ma, J. Berggren, M. Hammar, R. Soref, and W. Zhou, Appl. Phys. Lett., 96, 121107 (2010).
- [137] V. Q. Dang, G-S Han, T. Q. Trung, L. T. Duy, Y-U Jin, B-U. Hwang, H-S. Jung, N-E. Lee, Carbon 105, 353 (2016).
- [138] S. Chen,C. Teng,M. Zhang,Y. Li,D. Xie, and G. Shi, Adv. Mater. 28, 5969-5974 (2016).
- [139] K. Fukuda, T. Yokota, K. Kuribara, T. Sekitani, U. Zschieschang, H. Klauk, and T. Someya, Appl. Phys. Lett. 96, 17 (2010).
- [140] J. Park, S. Wang, M. Li, C. Ahn, J. K. Hyun, D. S. Kim, D. K. Kim, J. A. Rogers, Y. Huang, and S. Jeon, Nat. Commun. 3, 1 (2012).